# 74CBTLV3244

# 8-bit bus switch with 4-bit output enables Rev. 2 — 15 December 2011

**Product data sheet** 

#### 1. **General description**

The 74CBTLV3244 is a dual 4-pole, single-throw bus switch. The device features two output enable inputs (nOE) that each control four switch channels. The switches are disabled when the associated nOE input is HIGH. Schmitt trigger action at control inputs makes the circuit tolerant of slower input rise and fall times. This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

#### 2. **Features and benefits**

- Supply voltage range from 2.3 V to 3.6 V
- High noise immunity
- Complies with JEDEC standard:
  - ◆ JESD8-5 (2.3 V to 2.7 V)
  - ◆ JESD8-B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - CDM AEC-Q100-011 revision B exceeds 1000 V
- $\blacksquare$  5  $\Omega$  switch connection between two ports
- Rail to rail switching on data I/O ports
- CMOS low power consumption
- Latch-up performance exceeds 250 mA per JESD78B Class I level A
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



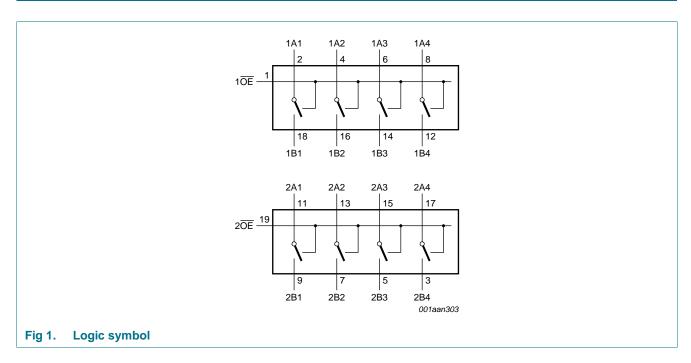
# 3. Ordering information

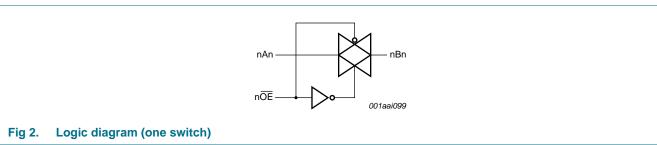
Table 1. Ordering information

| Type number   | Package           |           |  |          |
|---------------|-------------------|-----------|--|----------|
|               | Temperature range | Name      | Description  | Version  |
| 74CBTLV3244DS | –40 °C to +125 °C | SSOP20[1] | plastic shrink small outline package; 20 leads; body width 3.9 mm; lead pitch 0.635 mm   | SOT724-1 |
| 74CBTLV3244PW | –40 °C to +125 °C | TSSOP20   | plastic thin shrink small outline package; 20 leads; body width 4.4 mm   | SOT360-1 |
| 74CBTLV3244BQ | –40 °C to +125 °C | DHVQFN20  | plastic dual-in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body $2.5 \times 4.5 \times 0.85$ mm | SOT764-1 |

<sup>[1]</sup> Also known as QSOP20 package

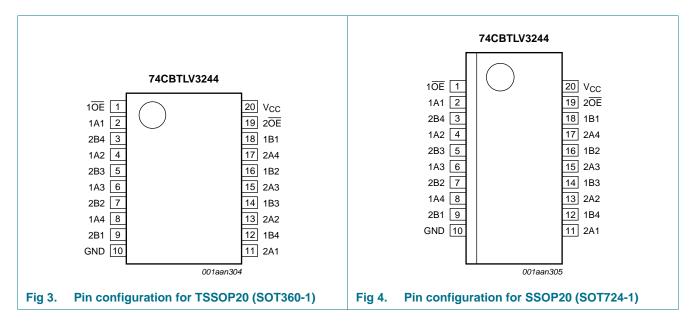
# 4. Functional diagram

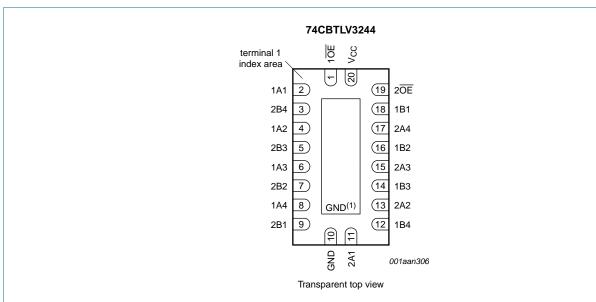




# 5. Pinning information

#### 5.1 Pinning





(1) This is not a supply pin. The substrate is attached to this pad using conductive die attach material. There is no electrical or mechanical requirement to solder this pad. However, if it is soldered, the solder land should remain floating or be connected to GND.

Fig 5. Pin configuration for DHVQFN20 (SOT764-1)

# 5.2 Pin description

Table 2. Pin description

| Symbol          | Pin            | Description                      |
|-----------------|----------------|----------------------------------|
| 10E, 20E        | 1, 19          | output enable input (active LOW) |
| 1A1 to 1A4      | 2, 4, 6, 8     | data input/output (A port)       |
| 2B1 to 2B4      | 9, 7, 5, 3     | data input/output (A port)       |
| GND             | 10             | ground (0 V)                     |
| 2A1 to 2A4      | 11, 13, 15, 17 | data input/output (B port)       |
| 1B1 to 1B4      | 18, 16, 14, 12 | data input/output (B port)       |
| V <sub>CC</sub> | 20             | positive supply voltage          |

# 6. Functional description

Table 3. Function selection[1]

| Input<br>nOE | Input/output |
|--------------|--------------|
| nOE          | nAn, nBn     |
| L            | nAn = nBn    |
| Н            | Z            |

<sup>[1]</sup> H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

# 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol           | Parameter               | Conditions   | Min             | Max            | Unit |
|------------------|-------------------------|--|-----------------|----------------|------|
| $V_{CC}$         | supply voltage          |  | -0.5            | +4.6           | V    |
| $V_{I}$          | input voltage           |  | <u>[1]</u> –0.5 | +4.6           | V    |
| $V_{SW}$         | switch voltage          | enable and disable mode  | <u>[1]</u> –0.5 | $V_{CC} + 0.5$ | V    |
| I <sub>IK</sub>  | input clamping current  | $V_{I} < -0.5 \text{ V}$   | -50             | -              | mA   |
| I <sub>SK</sub>  | switch clamping current | $V_{I} < -0.5 \text{ V}$   | -50             | -              | mA   |
| I <sub>SW</sub>  | switch current          | $V_{SW} = 0 V to V_{CC}$   | -               | ±128           | mA   |
| I <sub>CC</sub>  | supply current          |  | -               | +100           | mA   |
| $I_{GND}$        | ground current          |  | -100            | -              | mA   |
| T <sub>stg</sub> | storage temperature     |  | -65             | +150           | °C   |
| P <sub>tot</sub> | total power dissipation | $T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$ | [2] -           | 500            | mW   |

<sup>[1]</sup> The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>[2]</sup> For SSOP20 and TSSOP20 packages: above 60  $^{\circ}$ C the value of P<sub>tot</sub> derates linearly at 5.5 mW/K. For DHVQFN20 packages: above 60  $^{\circ}$ C the value of P<sub>tot</sub> derates linearly at 4.5 mW/K.

# 8. Recommended operating conditions

Table 5. Recommended operating conditions

| Symbol    | Parameter                           | Conditions                       | Min          | Max      | Unit |
|-----------|-------------------------------------|----------------------------------|--------------|----------|------|
| $V_{CC}$  | supply voltage                      |                                  | 2.3          | 3.6      | V    |
| $V_{I}$   | input voltage                       |                                  | 0            | 3.6      | V    |
| $V_{SW}$  | switch voltage                      | enable and disable mode          | 0            | $V_{CC}$ | V    |
| $T_{amb}$ | ambient temperature                 |                                  | -40          | +125     | °C   |
| Δt/ΔV     | input transition rise and fall rate | V <sub>CC</sub> = 2.3 V to 3.6 V | <u>[1]</u> _ | 200      | ns/V |

<sup>[1]</sup> Applies to control signal levels.

# 9. Static characteristics

Table 6. Static characteristics

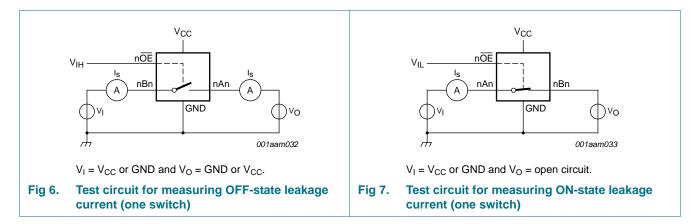
At recommended operating conditions voltages are referenced to GND (ground = 0 V).

| Symbol              | Parameter                    | Conditions  | T,         | amb = | –40 °C to | +85 °C | T <sub>amb</sub> = -40 ° | C to +125 °C | Unit |
|---------------------|------------------------------|---|------------|-------|-----------|--------|--------------------------|--------------|------|
|                     |                              |   | ı          | Min   | Typ[1]    | Max    | Min                      | Max          |      |
| $V_{IH}$            | HIGH-level                   | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$  |            | 1.7   | -         | -      | 1.7                      | -            | V    |
|                     | input voltage                | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$  |            | 2.0   | -         | -      | 2.0                      | -            | V    |
| $V_{IL}$            |                              | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$  |            | -     | -         | 0.7    | -                        | 0.7          | V    |
|                     | voltage                      | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$  |            | -     | -         | 0.9    | -                        | 0.9          | V    |
| I                   | input leakage current        | pin $\overline{\text{OE}}$ ; $V_{\text{I}} = \text{GND to } V_{\text{CC}}$ ; $V_{\text{CC}} = 3.6 \text{ V}$                      |            | -     | -         | ±1     | -                        | ±20          | μΑ   |
| I <sub>S(OFF)</sub> | OFF-state leakage current    | $V_{CC} = 3.6 \text{ V}$ ; see Figure 6   |            | -     | -         | ±1     | -                        | ±20          | μΑ   |
| I <sub>S(ON)</sub>  | ON-state<br>leakage current  | $V_{CC} = 3.6 \text{ V}$ ; see <u>Figure 7</u>  |            | -     | -         | ±1     | -                        | ±20          | μΑ   |
| I <sub>OFF</sub>    | power-off<br>leakage current | $V_1$ or $V_0 = 0$ V to 3.6 V;<br>$V_{CC} = 0$ V  |            | -     | -         | ±10    | -                        | ±50          | μΑ   |
| I <sub>CC</sub>     | supply current               | $V_I = GND \text{ or } V_{CC}; I_O = 0 \text{ A};$<br>$V_{SW} = GND \text{ or } V_{CC};$<br>$V_{CC} = 3.6 \text{ V}$              |            | -     | -         | 10     | -                        | 50           | μА   |
| $\Delta I_{CC}$     | additional supply current    | pin $\overline{\text{OE}}$ ; $V_{I} = V_{CC} - 0.6 \text{ V}$ ;<br>$V_{SW} = \text{GND or } V_{CC}$ ;<br>$V_{CC} = 3.6 \text{ V}$ | <u>[2]</u> | -     | -         | 300    | -                        | 2000         | μА   |
| C <sub>I</sub>      | input<br>capacitance         | pin $\overline{OE}$ ; $V_{CC} = 3.3 \text{ V}$ ; $V_I = 0 \text{ V}$ to 3.3 V   |            | -     | 0.9       | -      | -                        | -            | pF   |
| $C_{S(OFF)}$        | OFF-state capacitance        | $V_{CC} = 3.3 \text{ V}; V_I = 0 \text{ V to } 3.3 \text{ V}$   |            | -     | 5.2       | -      | -                        | -            | pF   |
| C <sub>S(ON)</sub>  | ON-state capacitance         | $V_{CC} = 3.3 \text{ V}; V_{I} = 0 \text{ V to } 3.3 \text{ V}$   |            | -     | 14.3      | -      | -                        | -            | pF   |

<sup>[1]</sup> All typical values are measured at  $T_{amb}$  = 25 °C.

<sup>[2]</sup> One input at 3 V, other inputs at  $V_{\mbox{\footnotesize CC}}$  or GND.

#### 9.1 Test circuits



#### 9.2 ON resistance

Table 7. Resistance R<sub>ON</sub>

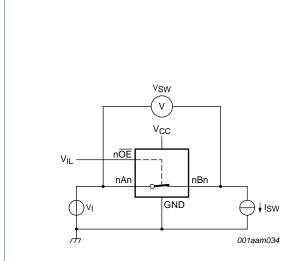
At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 8.

| Symbol               | Parameter     | Conditions  | T <sub>amb</sub> = | –40 °C to | +85 °C | T <sub>amb</sub> = -40 ° | °C to +125 °C | Unit |
|----------------------|---------------|---|--------------------|-----------|--------|--------------------------|---------------|------|
|                      |               |   | Min                | Typ[1]    | Max    | Min                      | Max           |      |
| R <sub>ON</sub> ON r | ON resistance | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V};$<br>see <u>Figure 9</u> to <u>Figure 11</u>  | 1                  |           |        |                          |               |      |
|                      |               | $I_{SW} = 64 \text{ mA}; V_I = 0 \text{ V}$   | -                  | 4.2       | 8.0    | -                        | 15.0          | Ω    |
|                      |               | $I_{SW} = 24 \text{ mA}; V_I = 0 \text{ V}$   | -                  | 4.2       | 8.0    | -                        | 15.0          | Ω    |
|                      |               | $I_{SW} = 15 \text{ mA}; V_I = 1.7 \text{ V}$   | -                  | 8.4       | 40     | -                        | 60.0          | Ω    |
|                      |               | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V};$<br>see <u>Figure 12</u> to <u>Figure 14</u> |                    |           |        |                          |               |      |
|                      |               | $I_{SW} = 64 \text{ mA}; V_I = 0 \text{ V}$   | -                  | 4.0       | 7.0    | -                        | 11.0          | Ω    |
|                      |               | $I_{SW} = 24 \text{ mA}; V_I = 0 \text{ V}$   | -                  | 4.0       | 7.0    | -                        | 11.0          | Ω    |
|                      |               | $I_{SW} = 15 \text{ mA}; V_I = 2.4 \text{ V}$   | -                  | 6.2       | 15     | -                        | 25.5          | Ω    |

<sup>[1]</sup> Typical values are measured at  $T_{amb}$  = 25 °C and nominal  $V_{CC}$ .

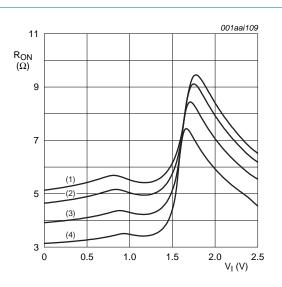
<sup>[2]</sup> Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

# 9.3 ON resistance test circuit and graphs



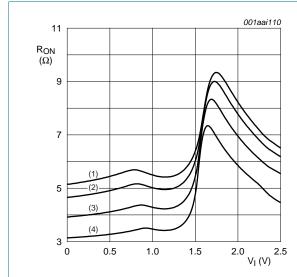
 $R_{ON} = V_{SW} / I_{SW}$ 

Fig 8. Test circuit for measuring ON resistance (one switch)



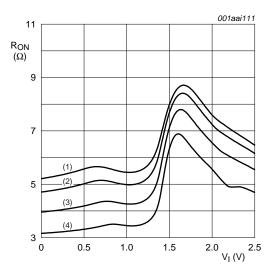
- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 9. ON resistance as a function of input voltage;  $V_{CC} = 2.5 \text{ V}$ ;  $I_{SW} = 15 \text{ mA}$ 



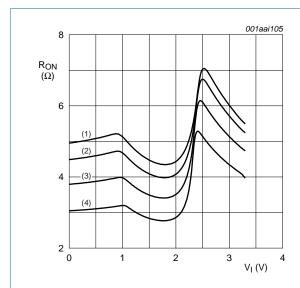
- (1)  $T_{amb} = 125 \, ^{\circ}C.$
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 10. ON resistance as a function of input voltage;  $V_{CC} = 2.5 \text{ V}; I_{SW} = 24 \text{ mA}$ 



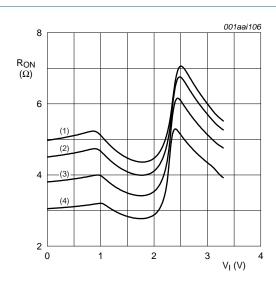
- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 11. ON resistance as a function of input voltage;  $V_{CC} = 2.5 \text{ V}$ ;  $I_{SW} = 64 \text{ mA}$ 



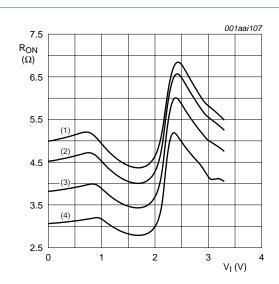
- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 12. ON resistance as a function of input voltage;  $V_{CC} = 3.3 \text{ V}; I_{SW} = 15 \text{ mA}$ 



- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 13. ON resistance as a function of input voltage;  $V_{CC} = 3.3 \text{ V}; I_{SW} = 24 \text{ mA}$ 



- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .
- (4)  $T_{amb} = -40 \, ^{\circ}C$ .

Fig 14. ON resistance as a function of input voltage;  $V_{CC} = 3.3 \text{ V}$ ;  $I_{SW} = 64 \text{ mA}$ 

# 10. Dynamic characteristics

Table 8. Dynamic characteristics

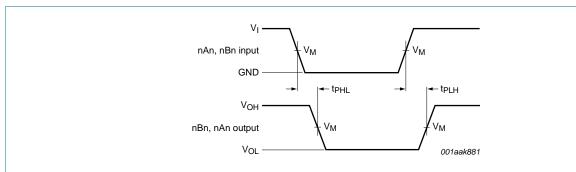
GND = 0 V; for test circuit see Figure 17

| Symbol            | Parameter         | Conditions  |            | T <sub>amb</sub> = | -40 °C to | +85 °C | $T_{amb} = -40$ ° | C to +125 °C | Unit |
|-------------------|-------------------|---|------------|--------------------|-----------|--------|-------------------|--------------|------|
|                   |                   |   | Min        | Typ[1]             | Max       | Min    | Max               |              |      |
| t <sub>pd</sub>   | propagation delay | nAn to nBn or nBn to<br>nAn; see <u>Figure 15</u> | [2][3]     |                    |           |        |                   |              |      |
|                   |                   | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$        |            | -                  | -         | 0.13   | -                 | 0.20         | ns   |
|                   |                   | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$        |            | -                  | -         | 0.20   | -                 | 0.31         | ns   |
| t <sub>en</sub> e | enable time       | nOE to nAn or nBn;<br>see Figure 16               | [4]        |                    |           |        |                   |              |      |
|                   |                   | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$        |            | 1.0                | 3.0       | 5.0    | 1.0               | 7.0          | ns   |
|                   |                   | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$        |            | 1.0                | 2.6       | 4.3    | 1.0               | 6.0          | ns   |
| t <sub>dis</sub>  | disable time      | nOE to nAn or nBn;<br>see Figure 16               | <u>[5]</u> |                    |           |        |                   |              |      |
|                   |                   | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$        |            | 1.0                | 2.6       | 5.5    | 1.0               | 7.5          | ns   |
|                   |                   | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$        |            | 1.0                | 3.2       | 5.5    | 1.0               | 7.5          | ns   |

<sup>[1]</sup> All typical values are measured at  $T_{amb}$  = 25 °C and at nominal  $V_{CC}$ .

- [3] t<sub>pd</sub> is the same as t<sub>PLH</sub> and t<sub>PHL</sub>.
- [4]  $t_{en}$  is the same as  $t_{PZH}$  and  $t_{PZL}$ .
- [5] t<sub>dis</sub> is the same as t<sub>PHZ</sub> and t<sub>PLZ</sub>.

#### 11. Waveforms



Measurement points are given in Table 9.

Logic levels:  $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical output voltage levels that occur with the output load.

Fig 15. The data input (nAn, nBn) to output (nBn, nAn) propagation delay times

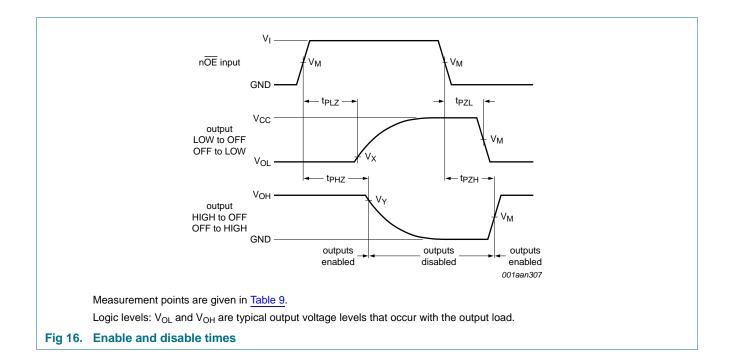
Table 9. Measurement points

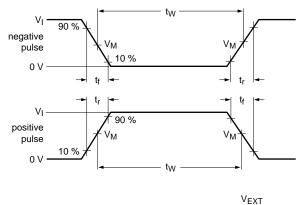
| Supply voltage  | Input              |                 |               | Output             |                          |                         |  |  |
|-----------------|--------------------|-----------------|---------------|--------------------|--------------------------|-------------------------|--|--|
| V <sub>CC</sub> | V <sub>M</sub>     | V <sub>I</sub>  | $t_r = t_f$   | V <sub>M</sub>     | V <sub>X</sub>           | V <sub>Y</sub>          |  |  |
| 2.3 V to 2.7 V  | 0.5V <sub>CC</sub> | $V_{CC}$        | $\leq$ 2.0 ns | 0.5V <sub>CC</sub> | V <sub>OL</sub> + 0.15 V | $V_{OH}-0.15\ V$        |  |  |
| 3.0 V to 3.6 V  | 0.5V <sub>CC</sub> | V <sub>CC</sub> | ≤ 2.0 ns      | 0.5V <sub>CC</sub> | V <sub>OL</sub> + 0.3 V  | V <sub>OH</sub> – 0.3 V |  |  |

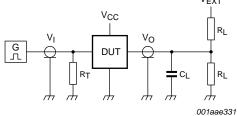
74CBTLV3244

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<sup>[2]</sup> The propagation delay is the calculated RC time constant of the on-state resistance of the switch and the load capacitance, when driven by an ideal voltage source (zero output impedance).







Test data is given in Table 10.

Definitions for test circuit:

 $R_L$  = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

V<sub>EXT</sub> = External voltage for measuring switching times.

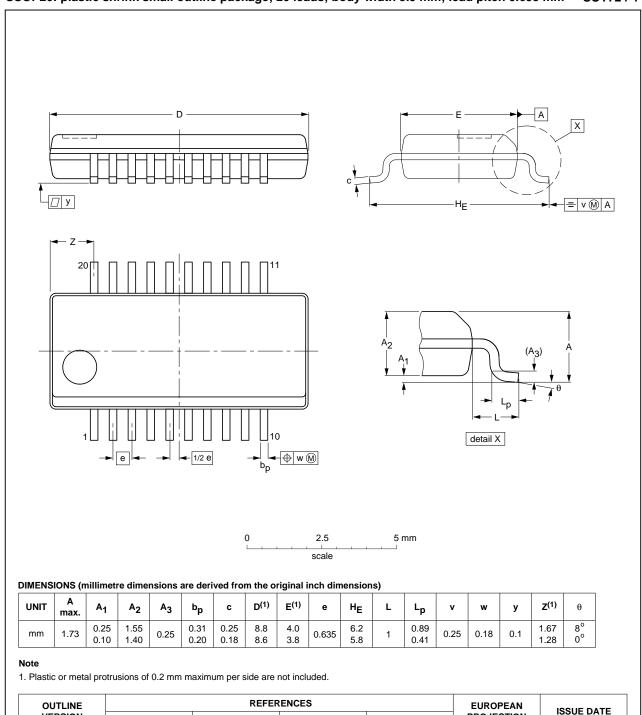
Fig 17. Test circuit for measuring switching times

Table 10. Test data

| Supply voltage  | Load           |                | V <sub>EXT</sub>                    |                                     |                                     |  |  |  |
|-----------------|----------------|----------------|-------------------------------------|-------------------------------------|-------------------------------------|--|--|--|
| V <sub>CC</sub> | C <sub>L</sub> | R <sub>L</sub> | t <sub>PLH</sub> , t <sub>PHL</sub> | t <sub>PZH</sub> , t <sub>PHZ</sub> | t <sub>PZL</sub> , t <sub>PLZ</sub> |  |  |  |
| 2.3 V to 2.7 V  | 30 pF          | 500 Ω          | open                                | GND                                 | 2V <sub>CC</sub>                    |  |  |  |
| 3.0 V to 3.6 V  | 50 pF          | 500 Ω          | open                                | GND                                 | 2V <sub>CC</sub>                    |  |  |  |

# 12. Package outline

SSOP20: plastic shrink small outline package; 20 leads; body width 3.9 mm; lead pitch 0.635 mm SOT724-1



| OUTLINE           |  | REFER  | EUROPEAN   | ISSUE DATE |                                  |
|-------------------|--|--------|------------|------------|----------------------------------|
| VERSION IEC JEDEC |  | JEITA  | PROJECTION | ISSUE DATE |                                  |
| SOT724-1          |  | MO-137 |            |            | <del>-01-07-04</del><br>03-02-18 |

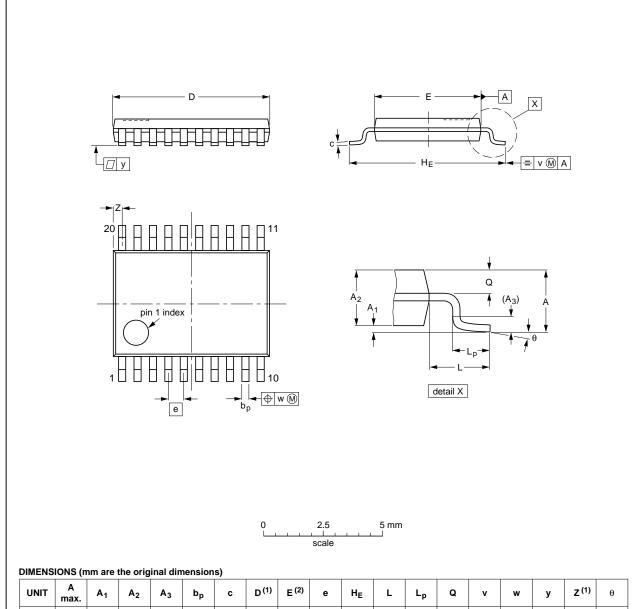
Fig 18. Package outline SOT724-1 (SSOP20)

74CBTLV3244

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TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



| UNIT | A<br>max. | A <sub>1</sub> | A <sub>2</sub> | A <sub>3</sub> | bp           | С          | D <sup>(1)</sup> | E (2)      | е    | HE         | L | Lp           | Q          | v   | w    | у   | Z <sup>(1)</sup> | θ        |
|------|-----------|----------------|----------------|----------------|--------------|------------|------------------|------------|------|------------|---|--------------|------------|-----|------|-----|------------------|----------|
| mm   | 1.1       | 0.15<br>0.05   | 0.95<br>0.80   | 0.25           | 0.30<br>0.19 | 0.2<br>0.1 | 6.6<br>6.4       | 4.5<br>4.3 | 0.65 | 6.6<br>6.2 | 1 | 0.75<br>0.50 | 0.4<br>0.3 | 0.2 | 0.13 | 0.1 | 0.5<br>0.2       | 8°<br>0° |

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

| OUTLINE<br>VERSION | REFERENCES |        |       | EUROPEAN | ISSUE DATE |                                 |
|--------------------|------------|--------|-------|----------|------------|---------------------------------|
|                    | IEC        | JEDEC  | JEITA |          | PROJECTION | ISSUE DATE                      |
| SOT360-1           |            | MO-153 |       |          |            | <del>99-12-27</del><br>03-02-19 |
|                    | I .        |        |       |          |            |                                 |

Fig 19. Package outline SOT360-1 (TSSOP20)

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DHVQFN20: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 x 4.5 x 0.85 mm SOT764-1

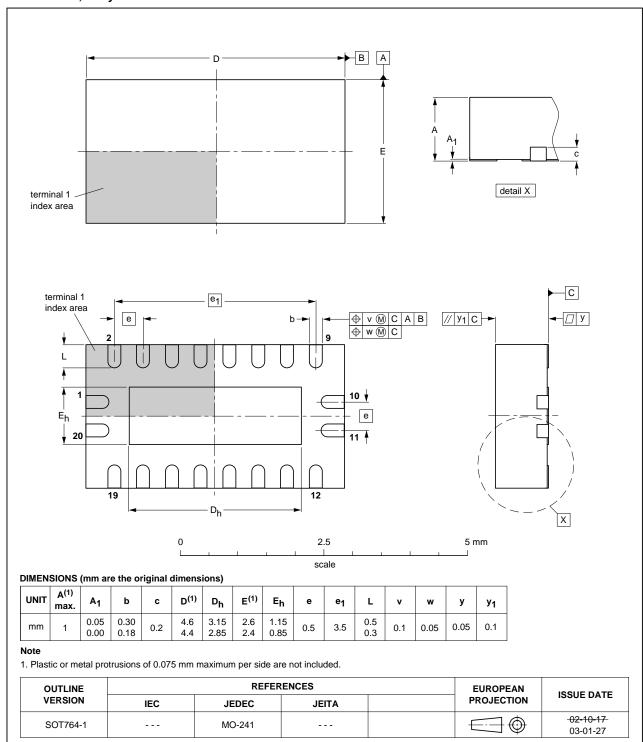


Fig 20. Package outline SOT764-1 (DHVQFN20)

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# 13. Abbreviations

#### Table 11. Abbreviations

| Acronym | Description                             |
|---------|---|
| CDM     | Charged Device Model                    |
| CMOS    | Complementary Metal-Oxide Semiconductor |
| DUT     | Device Under Test                       |
| ESD     | ElectroStatic Discharge                 |
| HBM     | Human Body Model                        |

# 14. Revision history

# Table 12. Revision history

| Document ID     | Release date         | Data sheet status  | Change notice | Supersedes      |
|-----------------|----------------------|--------------------|---------------|-----------------|
| 74CBTLV3244 v.2 | 20111215             | Product data sheet | -             | 74CBTLV3244 v.1 |
| Modifications:  | Legal pages updated. |                    |               |                 |
| 74CBTLV3244 v.1 | 20101228             | Product data sheet | -             | -               |

# 15. Legal information

#### 15.1 Data sheet status

| Document status[1][2]          | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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### 8-bit bus switch with 4-bit output enables

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